

Polarization, piezoelectric constants and elastic constants of ZnO, MgO and CdO

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Abstract

We report first principles density functional calculations of the spontaneous polarizations, piezoelectric stress constants and elastic constants for the II-VI wurtzite-structure oxides ZnO, MgO and CdO. Using our pseudopotential self-interaction corrected implementation of density functional theory, we obtain polarization values of -0.05, -0.17 and -0.10 C/m², and piezoelectric constants, e_{33} (e_{31}) of 1.34 (-0.57), 2.26 (-0.38) and 1.67 (-0.48) C/m² for structurally relaxed ZnO, MgO and CdO respectively. These properties are consistently larger in magnitude than the corresponding GaN, AlN and InN analogues. Therefore we predict that larger internal fields will be attainable in ZnO-based polarization field effect transistors than in equivalent GaN-based devices.

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Over the past decade, nitride-based III-V semiconductors have emerged as leading contenders for many technological applications, particularly in optoelectronics (blue and green lasers and light emitting diodes ^{1,2}), and microelectronics (high electron mobility transistors³). Their utility in optoelectronics stems in large part from their wide range of direct band gaps - 0.7 eV in InN, 3.4 eV in GaN, and 6.3 eV in AlN - combined with their ability to form complete solid solutions, which provides the entire spectrum of emission wavelengths from 1800 nm (infra-red) to 200 nm (ultra-violet). In addition, the macroscopic polarization associated with the wurtzite crystal structure plays an important role in determining the electrical and optical properties. This is particularly important in heterostructures where a difference in polarization between layers induces an electric field at the interface, which in turn is screened by the formation of a two-dimensional electron gas (2DEG). The electron mobility in such polarization-induced 2DEGs can be much higher than that in traditional impurity-doped systems, in which the electrons scatter from ionized impurities. Thus high speed transistors known as POLFETs (polarization field effect transistors) can be produced³.

Presently, there is growing interest in ZnO-based materials as alternatives to the nitrides. Indeed many properties of ZnO are similar, if not superior to those of GaN. Perhaps most importantly, and in striking contrast to GaN, single crystals of ZnO can be grown readily⁴, and used as substrates for the growth of thin film devices. This facilitates the production of much higher quality films using homoepitaxy, and circumvents the problems associated with dislocation formation from epitaxial mismatch that plagues GaN growth. In addition, the exciton binding energy of ZnO (60 meV) is twice as large as that of GaN, leading to stronger electron-hole recombination and thus improved optical efficiency⁵. Finally, the band gap of ZnO (3.4 eV) is very close to that of GaN, and it can likewise be varied systematically by alloying with MgO^{6,7} or CdO⁸. However, since MgO and CdO do not occur in the wurtzite structure, values of the electronic and elastic properties, crucial for the modeling of heterojunction device performance⁹, cannot be obtained experimentally.

In this work we calculate the spontaneous polarizations, piezoelectric coefficients and elastic constants of wurtzite-structure MgO, ZnO and CdO. We calculate the optimized structures of the three materials using the standard local density approximation (LDA) to density functional theory as implemented in the VASP package^{10,11}. We then use our recently-developed pseudopotential self-interaction corrected (pseudo-SIC) implementation¹² of the density functional formalism to calculate the electronic properties, because the LDA fails

to obtain a band gap for wurtzite-structure CdO, preventing the calculation of its polarization. The polarizations are obtained using the widely-used Berry phase method^{13,14}, and the piezoelectric coefficients and elastic constants are obtained from the calculated dependence of polarization and energy on the appropriate strain. Our polarizations are reported relative to the conventional reference structure of the zincblende structure with the same ratio of c lattice constant to unit cell volume¹⁵, and care is taken to avoid problems associated with the branch dependence of the polarization by extracting the so-called *proper* piezoelectric response for the e_{31} coefficients¹⁶. Our main result is that the polarization magnitudes and polarization gradients are all larger in the ZnO-based system than in the GaN-based system, suggesting ZnO as a promising candidate for the development of polarization field-effect transistors.

Before reporting our polarization results, we compare our pseudo-SIC band structures with those that we obtain using the LDA (Figure 1), at the calculated LDA lattice parameters. It is clear that our calculated pseudo-SIC band gap of ZnO (3.8 eV) is in good agreement with the experimental value (3.4 eV¹⁷), whereas the LDA shows the usual underestimation (0.78 eV). CdO and MgO occur naturally in the rock-salt structure with band gaps of ~ 1 eV (indirect) or 2.4 eV (direct) for CdO¹⁷ and ~ 7.7 eV for MgO¹⁷; although our calculated band gaps for the wurtzite structure should not match exactly, they are of a similar magnitude.

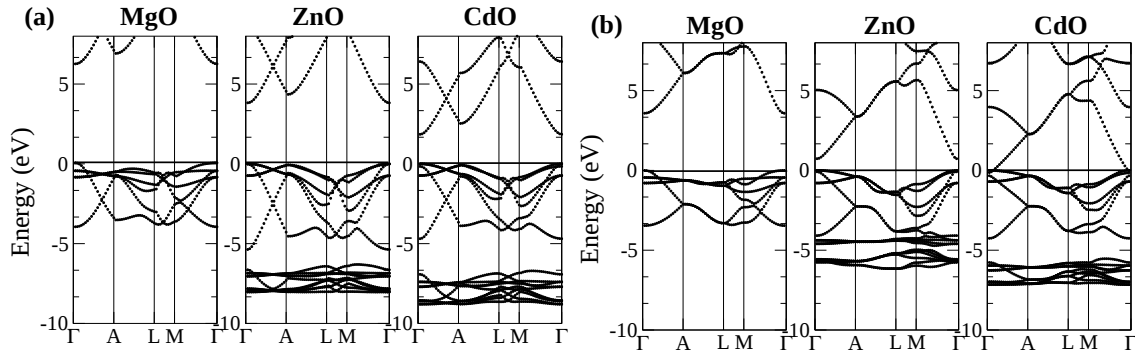


FIG. 1: Band structures of MgO, ZnO and CdO within (a) pseudo-SIC and (b) LDA approaches, at the calculated optimized LDA lattice parameters. Notice that the LDA severely underestimates the band gap, and results in a metallic ground state for CdO; this prevents the calculation of the polarization and piezoelectric coefficients.

		P	e_{33}	e_{31}
II-VIs	MgO	-0.173	2.26	-0.38
	ZnO	-0.048	1.34	-0.57
	CdO	-0.099	1.67	-0.48
III-Vs	AlN	-0.081	1.46	-0.60
	GaN	-0.029	0.73	-0.49
	InN	-0.032	0.97	-0.57

TABLE I: Polarizations, P , and piezoelectric constants, e_{33} and e_{31} , in C/m², for II-VI oxides (this work), and III-V nitrides (from Ref. 15), calculated at the theoretical LDA equilibrium lattice parameters.

When a wurtzite-structure semiconductor is constrained by epitaxial matching to a substrate or in a heterostructure, its total polarization is the sum of its intrinsic spontaneous polarization, P_{sp} (that is the polarization that it would have in an unstrained bulk sample) plus the polarization induced as a result of the strain, $P_{pz}(\epsilon)$. The strain-induced component depends strongly on the strain, ϵ , and hence on the lattice mismatch between the epitaxial layers; in the linear regime it is related to the piezoelectric tensor, e , by

$$P_{pz(i)} = \sum_j e_{ij} \epsilon_j. \quad (1)$$

Both the intrinsic and strain-induced contributions can be calculated accurately from first principles calculations^{13,14,15,18}, and have been shown to be large in the III-V nitrides¹⁵.

We begin by calculating the polarization and piezoelectric constants (e_{33} and e_{31}) at the calculated LDA equilibrium structures for MgO ($a = 3.26$ Å, $c/a = 1.51$, $u = 0.398$), ZnO ($a = 3.20$ Å, $c/a = 1.61$, $u = 0.378$) and CdO ($a = 3.60$, $c/a = 1.55$, $u = 0.391$); our results are reported in Table I. For comparison we also report the literature values calculated for the nitrides at their theoretical LDA lattice parameters and u values¹⁹. (Note that our reported polarization for LDA ZnO (-0.048 C/m²) differs slightly from the literature value (-0.057 C/m²)¹⁵ because we use our pseudo-SIC approach; if we repeat our calculations using the LDA we reproduce the earlier value. Likewise, our pseudo-SIC piezoelectric constants are slightly different from literature LDA values^{15,20}.)

Notice that the polarizations are larger in every case for the oxide materials than for their

nitride analogues. Perhaps more importantly, the polarization *gradients* between the end-point materials are considerably larger in the ZnO-based system. This is illustrated in Fig. 2, where we compare our polarizations for MgO, ZnO and CdO with the literature values for AlN, GaN and InN, all at the theoretical equilibrium structures. The straight lines indicate the Vegard's Law projections for the polarizations of intermediate alloy compositions.

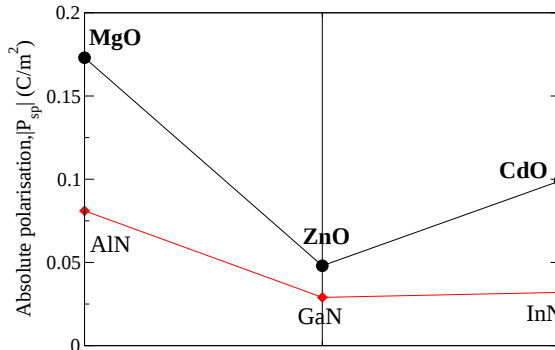


FIG. 2: Calculated absolute polarization values of the II-VI oxides ZnO, MgO and CdO (this work) and their III-V nitride analogues GaN, AlN and InN (from Ref. 15).

In principle, the polarization in any other strain state can then be obtained from the equilibrium values shown in Table I using Eqn. 1. However, since the experimental bond lengths depend sensitively on the details of the structure, and could in fact be distorted beyond the linear regime described by Eqn. 1, we also calculate the polarization from first principles in two other limits: First, at the experimental ZnO lattice parameters and atomic positions ($a = 3.25$ Å, $c/a = 1.60$, $u = 0.382^{17}$). This represents the situation in which only small amounts of Mg or Cd are doped into ZnO so that the structure does not change significantly. And second, we constrain the in-plane lattice parameter a to that of experimental ZnO, and allow the structure to relax perpendicular to the plane (along the c direction) to simulate the situation in epitaxial films.

Our results are shown in Table II. It is clear from the first column (calculated using the ZnO experimental coordinates) that, when the ions are constrained to have the same ionic positions, the polarizations of the three materials are rather similar. Therefore differences in polarizations in real systems must result primarily from the relaxations of the ions. The second column of data in Table II indicates that when MgO is allowed to relax out of plane, there is a large increase (almost double) in the polarization; this is caused by a contraction

P	
(i)	(ii)
MgO	-0.067 -0.152
ZnO	-0.073 -0.081
CdO	-0.073 -0.013

TABLE II: Polarization values for the II-VI oxides calculated (i) at the ZnO experimental atomic positions and lattice parameters, and (ii) with the a parameter constrained to the experimental ZnO value, and the theoretical relaxed c parameters and atomic positions.

of the c parameter during the structural optimization (c/a reduces from 1.60 to 1.52 and u changes from 0.382 to 0.395). Similarly the the large (factor of six) decrease which we find for CdO is caused by an out-of-plane expansion ($c/a= 1.87$, $u = 0.357$) to accommodate the applied in-plane compression. However the polarization of ZnO is almost unchanged from that at the experimental coordinates, because there is negligible change in the c lattice parameter on relaxation. Note also that the polarization of MgO is similar to that at its calculated equilibrium parameters (Table I), because the calculated equilibrium parameters are not dissimilar to those with the in-plane constraint.

Finally, (Table III) we report the elastic constants (C_{11} , C_{12} , C_{33} , C_{13} , and C_{44}) obtained by calculating the change in energy with strain for five different strain configurations. The details of the strain configurations used and the procedure for extracting the elastic constants are described in Ref. 21. For comparison, the experimental values for ZnO, obtained using the Brillouin light scattering technique on polycrystalline films²² are also included in the table. Note that the agreement between our calculated values and the measured values for ZnO is very good. We expect our calculated values for hypothetical wurtzite-structure MgO and CdO to be similarly appropriate.

In summary, we have calculated the spontaneous polarizations, piezoelectric coefficients and elastic constants for wurtzite-structure MgO, ZnO and CdO. For ZnO our results agree well with previous calculations and with experimental data; for MgO and CdO (which are experimentally inaccessible in the wurtzite structure) we provide predictions. We find that the absolute polarizations and the polarization gradients between end-point compounds are larger in the ZnO system than in the GaN system.

	C_{11}	C_{12}	C_{33}	C_{13}	C_{44}
MgO	222	90	109	58	105
calculated ZnO	217	117	225	121	50
CdO	150	108	105	61	47
measured ZnO	206	118	211	118	44

TABLE III: Elastic constants for wurtzite-structure MgO, ZnO and CdO calculated at the theoretical equilibrium lattice parameters and atomic positions (this work) and measured using Brillouin light scattering (Ref. 22).

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- ¹ S. Nakamura and G. Fasol, *The Blue Laser Diode* (Springer, Berlin, 1997).
- ² S. Nakamura and S. F. Chichibu, *Introduction to Nitride Semiconductor Blue Laser and Light-Emitting Diodes* (Taylor and Francis, London, 2000).
- ³ U. K. Mishra, Y. F. Wu, B. P. Keller, S. Keller, and S. P. Denbaars, IEEE Transactions on Microwave Theory and Techniques **46**, 756 (1998).
- ⁴ D. P. Norton, Y. W. Heo, M. P. Ivill, K. Ip, S. J. Pearton, M. F. Chisholm, and T. Steiner, Materials Today **7**, 34 (2004).
- ⁵ D. C. Reynolds, D. C. Look, and B. Jogai, Solid State Comm. **99**, 873 (1996).
- ⁶ A. Ohtomo, M. Kawasaki, T. Koida, K. Masubuchi, H. Koinuma, Y. Sakurai, Y. Yoshida, T. Yasuda, and Y. Yoshida, Appl. Phys. Lett. **72**, 2466 (1998).
- ⁷ A. Ohtomo, M. Kawasaki, I. Ohkubo, H. Koinuma, T. Yasuda, and Y. Segawa, Appl. Phys. Lett. **75**, 980 (1999).
- ⁸ T. Makino, Y. Segawa, M. Kawasaki, A. Ohtomo, R. Shoroki, K. Tamura, T. Yasuda, and H. Koinuma, Appl. Phys. Lett. **78**, 1237 (2001).
- ⁹ F. Sacconi, A. D. Carlo, P. Lugli, and H. Morkoc, IEEE Transactions on Electron Devices **48**,

450 (2001).

- ¹⁰ G. Kresse and J. Furthmüller, Phys. Rev. B. **54**, 11169 (1996).
- ¹¹ G. Kresse and D. Joubert, Phys. Rev. B. **59**, 1758 (1999).
- ¹² A. Filippetti and N. A. Spaldin, Phys. Rev. B. **67**, 125109 (2003).
- ¹³ R. D. King-Smith and D. Vanderbilt, Phys. Rev. B. **47**, 1651 (1993).
- ¹⁴ R. D. King-Smith and D. Vanderbilt, Phys. Rev. B. **48**, 4442 (1993).
- ¹⁵ F. Bernardini, V. Fiorentini, and D. Vanderbilt, Phys. Rev. B. **56**, R10024 (1997).
- ¹⁶ D. Vanderbilt, J. Phys. Chem. Solids. **61**, 147 (2000).
- ¹⁷ *Landolt-Börnstein - Group III Condensed Matter* (Springer-Verlag, Heidelberg, 2002).
- ¹⁸ R. Resta, Rev. Mod. Phys. **66**, 899 (1994).
- ¹⁹ A. Zoroddu, F. Bernardini, P. Ruggerone, and V. Fiorentini, Phys. Rev. B. **64**, 045208 (2001).
- ²⁰ A. D. Corso, M. Posternak, R. Resta, and A. Baldereschi, Phys. Rev. B. **50**, 10715 (1994).
- ²¹ A. F. Wright, J. Appl. Phys. **82**, 2833 (1997).
- ²² G. Carlotti, D. Fioretto, G. Socino, and E. Verona, J. Phys. Cond. Matter. **7**, 9147 (1995).